

CURRICULUM VITAE



Dr. Bhawesh Kumar Thakur

Designation: Professor & Head (IT)

Department: Information Technology

Official Email ID: bhaweshkthakur@iitbafest.ac.in

**ACADEMIC/INDUSTRIAL EXPERIENCE:- 20 Years (Academic: 17 Years/
Industry:03 Years)**

QUALIFICATION: - M. Tech (CS), Ph.D.

AREA OF INTEREST:- Data Mining, Artificial Intelligence

RESEARCH PUBLICATION:-

- [1] Viney Yashvi, Dr. Ansh P. Tripathi, Dr. Bhawesh Kumar Thakur, (2021), 'Efficient Band Traffic Management Using Fuzzy And Genetic Approaches', Design Engineering, Issue 4, Pages: 2361 - 2363, 2021 (Accepted)
- [2] Praveen Kumar Tripathi, Vinod Anandhi, Dr. Bhawesh Kumar Thakur, (2020), 'Quantum Cryptography: An Improved Technique For Information Security', in International Conference on Challenges & Opportunities For Technological Innovations in India-ICOTII-2020
- [3] Thakur, Bhawesh Kumar and Abbas, Dr. Syed Qasim, (2018), 'Web Usage Mining Based Personalization Systems: A Review and Implementation', Global Journal Of Engineering Science And Research (GJESR), pp.252-256.
- [4] Sahil Shukla, Supriya Mishra and Thakur, Bhawesh Kumar, (2018), 'A Survey: User Identification Techniques for Customization of Web Page', International Journal of Computer Science and Information Technologies (IJCSIT), Vol.7, No.6, pp.3426-3430.
- [5] Thakur, Bhawesh Kumar and Abbas, Dr. Syed Qasim and Beg, Dr. Mohd. Rizwan and Rishi Shrestha, (2017), 'Automated Tool For Web User Identification', International Journal of Research in Engineering and Advanced Technology (IJEAT), Volume 3, Issue 4, pp.75-80.
- [6] Thakur, Bhawesh Kumar and Abbas, Dr. Syed Qasim and Beg, Dr. Mohd. Rizwan and Rishi Shrestha, (2017), 'Preprocessing Of Web Usage Data For Log Analysis', International Journal of Scientific & Engineering Research (IJSER), Volume 6, Issue 6, pp.1775-1779.
- [7] Thakur, Bhawesh Kumar and Abbas, Dr. Syed Qasim and Beg, Dr. Mohd. Rizwan, (2014), 'Web Personalization Using Clustering Of Web Usage Data', International Journal in Foundations of Computer Science & Technology (IJFCST), Vol.4, No.5, pp.69-84.